

Notic of References Cit d

Application/Control No.

09/343,872

Applicant(s)/Patent Under
Examination
DIAO ET AL.

Examiner

Kim Huynh

Art Unit

2181

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,148,356	11-2000	Archer et al.	710
	B	US-6,092,141	07-2000	Lange	710
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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